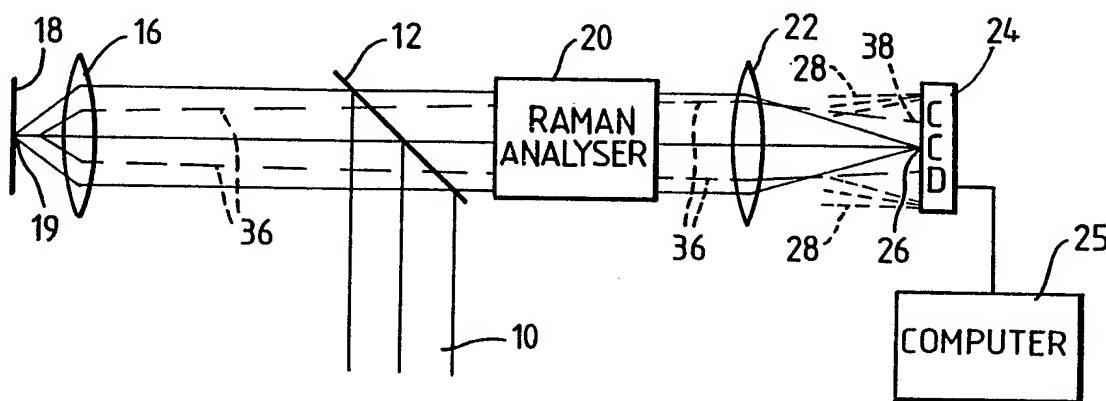




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## (54) Title: CONFOCAL SPECTROSCOPY



## (57) Abstract

A spot (19) of a sample (18) is illuminated by laser light (10). Raman scattered light is collimated in a parallel beam by a microscope objective (16), and analysed by a dispersive or non-dispersive analyser (20) (such as a diffraction grating or filter). A lens (22) then focuses the Raman scattered light onto a two-dimensional photodetector array in the form of a charge-coupled device (CCD) (24). A confocal technique is described to eliminate light (36) scattered from outside the focal plane of the objective (16). This may be done by binning together a few pixels of the CCD at the focal point (26) of the lens (22), or by image processing techniques in a computer (25).

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## CONFOCAL SPECTROSCOPY

BACKGROUND OF THE INVENTION

5 This invention relates to apparatus and methods in which spectroscopy is used to analyse a sample, for example making use of the Raman effect.

10 The Raman effect is a phenomenon in which a sample scatters incident light of a given frequency, into a frequency spectrum which has lines caused by interaction of the incident light with the molecules making up the sample. Different molecular species have different characteristic Raman spectra, and so the effect can be used to analyse the 15 molecular species present.

Prior arrangements of Raman analysis apparatus have been described in a paper "Raman Microprobe and Microscope with Laser Excitation", M Delhaye and P Dhamelincourt, Journal 20 of Raman Spectroscopy, 3 (1975), 33-43, and also in our earlier International Patent Specification WO 90/07108. A sample is irradiated with monochromatic light from a laser, and the scattered light is analysed in order to select a particular line of the resulting Raman spectrum. The 25 analysis may be performed by a dispersive device such as a diffraction grating, e.g. in a monochromator, or it may be performed as described in WO 90/07108 using a non-dispersive tunable filter. WO 90/07108 also discloses that the resulting Raman scattered light may be focused onto a 30 charge-coupled device (CCD), which is a two-dimensional photo-detector array.

Other spectroscopic techniques are also known in which a sample is irradiated with monochromatic or even 35 polychromatic light, and the light scattered is analysed. Examples include fluorescence spectroscopy and infra-red spectroscopy. The present invention is also applicable to such techniques.

It is possible to use such techniques in a confocal manner, in order to analyse only light scattered from a certain plane in the sample. This involves passing the scattered light through a spatial filter, comprising a very small 5 pinhole (typically 10 $\mu\text{m}$ ) at the focus of a lens system. Light scattered from the required plane is brought to a tight focus at the pinhole and passes through, whereas light from other planes is not so tightly focused and is blocked. However, such a spatial filter is difficult to 10 set up correctly, because of the need for careful alignment of the optical components to ensure tight focusing of the scattered light on the very small pinhole. For the same reason, it is difficult to maintain the optical components correctly in alignment after the initial setting up, and 15 the system is also susceptible to vibration. The alignment is particularly difficult to perform in systems where only very low levels of scattered light are available for analysis, such as Raman systems, since it is then impossible to see the focused light.

20

SUMMARY OF THE INVENTION

The present invention provides a spectroscopy method comprising:

25 illuminating a sample, to obtain therefrom a spectrum of scattered light;  
analysing said spectrum;  
passing at least one component of the analysed spectrum to a photodetector, light scattered from a given plane in  
30 the sample being focused on the photodetector while light scattered from other planes in the sample is not in focus on the photodetector; and  
detecting light which is in focus on the photodetector, thereby reducing the effect of light scattered from said  
35 other planes in the sample.

The invention also provides apparatus for performing this method.

BRIEF DESCRIPTION OF THE DRAWINGS

Fig 1 is a schematic diagram of a first embodiment of Raman analysis apparatus,

5 Figs 2 and 3 are schematic plan views of parts of a CCD when used with the apparatus of Fig 1,

Fig 4 is a schematic diagram of further embodiments of Raman analysis apparatus,

Fig 5 is a schematic plan view of part of a CCD when 10 used with the embodiments in Fig 4, and

Figs 6 and 7 are plan views of a CCD, used for explaining another embodiment of Raman analysis apparatus.

DESCRIPTION OF PREFERRED EMBODIMENTS

15

The first embodiment of the apparatus illustrated in Fig 1 is based upon the apparatus shown in WO 90/07108, which is incorporated herein by reference and to which the reader should refer for further details. An input laser beam 10 20 is reflected through 90° by a dichroic filter 12, placed at 45° to the optical path. The laser beam then passes to a microscope objective lens 16, which focuses it to a spot at its focal point 19 on a sample 18. Light is scattered by the sample at this illuminated spot, and is collected by 25 the microscope objective 16 and collimated into a parallel beam which passes back to the dichroic filter 12. The filter 12 rejects Rayleigh scattered light having the same frequency as the input laser beam 10, and transmits the Raman scattered light. The Raman scattered light then 30 passes to a Raman analyser 20.

The Raman analyser 20 may comprise one or more tunable non-dispersive filters for selecting a Raman line of interest, as disclosed in WO 90/07108. Alternatively, it may 35 comprise a dispersive element such as a diffraction grating, either in a conventional monochromator arrangement or in the arrangement described in our UK Patent Application No. 9124408.7. In either case, the light from

the analyser 20 is focused by a lens 22 onto a suitable photo-detector. A two-dimensional photo-detector array is preferred. In the present embodiment a charge-coupled device (CCD) 24 is used, which consists of a two-dimensional array of pixels, and which is connected to a computer 25 which acquires data from each of the pixels and analyses it as required. Where the Raman analyser 20 comprises a tunable non-dispersive filter, light of the selected Raman frequency is focused at 26 on the CCD 24.

10 Where a dispersive element such as a diffraction grating is used, the analyser 20 produces not a single spot but a spectrum having various bands as indicated by broken lines 28, spread out in a line along the CCD 24.

15 Light from the focal point 19 of the lens 16 is brought to a tight focus at 26 on the CCD. However, as illustrated by the broken lines 36, light from in front of or behind the focal point 19 is brought to a more diffuse focus. In the case where a non-dispersive filter is used for the analyser 20, the effect is illustrated in Fig 2 which is a plan view of part of the CCD 24. Individual pixels of the CCD are shown as squares 40. The pixels may typically have a pitch of 22 $\mu$ m or less. A circle 26 represents the distribution of light scattered from the focal point 19, while a circle 25 38 represents the more diffuse focus of light scattered from elsewhere in the sample. When analysing data, the computer 25 bins together a few pixels 42, shown shaded, which receive the light focused at 26. Extraneous light from elsewhere within the circle 38 is ignored by the computer. This is readily achieved by computer software which reads the data from each pixel 40 serially, in turn, adding together the data from the pixels 42 and ignoring the rest.

35 The combination of the CCD with the computer thus gives the same effect as the pinhole in a conventional spatial filter. If the lens 16 is focused on the surface of the sample, it is possible to filter out light scattered from

behind the surface within the sample, so that analysis of the surface itself may be carried out. Alternatively, it is possible to deliberately focus the lens 16 to a point within the sample, thereby filtering out light scattered 5 from the surface. Thus confocal behaviour has been achieved without the use of an extra spatial filter.

When a diffraction grating or other dispersive element is used as the analyser 20 in Fig 1, and it is desired to view 10 a full Raman spectrum rather than just a single Raman band, full confocal spectroscopy is not possible with such simple software. Partial confocal behaviour can be achieved, however, by operating the CCD 24 and computer 25 as indicated in Fig 3. The diffraction grating disperses the 15 Raman spectrum from the sample across the CCD in a line. The width of the line is smallest for light which has been scattered from the focal point 19, for example in the unshaded region between the lines 44 on the CCD in Fig 3. Light from planes outside the focal plane which contains 20 the focal point 19 would be scattered into a broader line, such as defined between the lines 46 in Fig 3. To obtain partial confocal behaviour, therefore, the computer 25 is programmed (in a similar manner to that described above) to capture data only from those pixels of the CCD lying in the 25 region between the lines 44, and excluding light received elsewhere on the CCD. This excludes light received in the shaded region of Fig 3 from outside the focal point 19.

The reason that the arrangement of Fig 3 exhibits only 30 partial confocal behaviour is because the spatial filtering provided by the CCD and computer occurs only in one dimension and not two. This can be overcome by using the embodiment of Fig 4, consisting of the same elements as found in Fig 1, with the addition of a spatial filter 14. 35 The same reference numbers have been used as in Fig 1.

The spatial filter 14 comprises two lenses 32,34, and a screen 31 having a slit 30, extending normal to the plane

of the paper. The lens 32 focuses the parallel beam of scattered light down to a very tight focus which passes through the slit 30, and the lens 34 collimates the light back into a parallel beam. The input laser beam 10 is 5 likewise focused down to a very small spot to pass through the slit 30. The effect of the slit 30 is that the microscope objective 16 acts confocally. That is, substantially only the light scattered at the focal point 19 of the lens 16 passes through the slit 30. As indicated 10 by broken lines 36, light which is scattered in front of or behind the focal point 19 is not brought to a focus at the aperture 30, and is therefore substantially blocked by the screen 31.

15 Fig 5 is a plan view, corresponding to Figs 2 and 3, of the CCD when used with the embodiment of Fig 4. Light passing through the slit 30 is dispersed by the diffraction grating analyser 20 into individual bands 28 of the Raman spectrum. Without the slit 30, light corresponding to the bands 28, 20 but scattered from outside the focal point 19, would appear in broader regions lying between the pairs of broken lines 48,50. It will be appreciated that the slit 30 provides only one-dimensional spatial filtering, such that each of the Raman bands 28 has been spatially filtered in the 25 horizontal direction of Fig 5. However, some light from outside the focal point 19 can still pass through the slit 30 and be received in the area of Fig 5 which corresponds to the shaded regions of Fig 3. To overcome this, the computer 25 is programmed as in the Fig 3 embodiment, to 30 process only data from the pixels lying between the lines 44 and to exclude the other pixels lying between the lines 46. This provides spatial filtering in the vertical direction, and together with the horizontal spatial filtering provided by the slit 30, full two-dimensional 35 confocal behaviour is achieved.

An advantage of this arrangement over an arrangement in which a pinhole is used instead of the slit 30, is that it is much easier to align a slit than a pinhole.

5 If desired, it is possible to provide the dichroic filter in the position indicated in broken lines at 12A in Fig 4, instead of in the position indicated at 12. The laser beam then enters the system at 10A, instead of 10. This arrangement has the advantage that the input laser beam  
10 10 does not have to pass through the spatial filter 14. Consequently, there is no risk of the laser beam hitting the edges of the aperture 30 and causing scattering from there. Such scattering would be undesirable, since unless the edges of the aperture are kept extremely clean, any  
15 dirt will cause unknown Raman scattered light to pass through the analyser 20 and be registered on the CCD 24. Conversely, however, arranging the dichroic filter at the position 12 has the advantage that the easily visible laser light can be used to adjust the positioning the aperture 30  
20 20 when setting the apparatus up. With the dichroic filter at 12A, the Raman scattered light passing through the dichroic filter to the spatial filter 14 is insufficient to be visible. Furthermore, placing the dichroic filter at 12 means that the spatial filter 14 can easily be added to the  
25 25 existing apparatus as described in WO 90/07108, between the microscope and the remainder of the apparatus, and is easily accessible for adjustment.

In order to act as a spatial filter, the width of the slit  
30 30 should be very small, typically 10 $\mu\text{m}$  or even less. A maximum width might be 50 $\mu\text{m}$ . Thus, the slit 30 should not be confused with the entrance and exit slits commonly provided in conventional monochromators which are much larger, say 200 $\mu\text{m}$  at the least, in order to collect an  
35 35 adequate amount of light.

The various examples of the invention described above have used a CCD as the detector. However, to detect light in

the circle 26 in Fig 2, while rejecting light outside this circle, it is possible to use a single photo-detector of the correct size, e.g. an avalanche photodiode. This arrangement can also be used to detect a single Raman band 5 produced by a diffraction grating. To detect the light between the lines 44 in Figs 3 and 5, while rejecting other light, it is possible to use a one-dimensional (i.e. linear) photo-detector array having an appropriate width.

10

A further possibility is to use those pixels of the CCD which are not otherwise used (e.g. those outside the circle 38 (Fig 2) or outside the lines 46 (Figs 3 and 5)) to detect the DC level of background light. This can then be 15 subtracted by the computer 25 from the signals produced by the pixels of interest.

Figs 4 and 5 above have illustrated how full confocal behaviour can be obtained when a dispersive device such as 20 a diffraction grating is used as the analyser 20. Figs 6 and 7 will now be used to describe techniques in which similar results are achieved, but without the need for the spatial filter 14 (that is, using hardware as shown in Fig 1). These techniques involve the use of more sophisticated 25 image processing software within the computer 25, to analyse the data received from the CCD 24. Compared with the embodiment of Figs 4 and 5, therefore, these techniques have the advantage of a simpler and cheaper opto-mechanical arrangement, at the expense of computer processing which is 30 more time consuming and which may require a larger computer.

Fig 6 is a view of the CCD 24 corresponding to Fig 3, but showing more detail. The bands of the Raman spectrum 35 produced by the dispersive analyser 20 (in an idealised case) are indicated by the small spots 60, lying within the lines 44. Such an idealised picture would only be

obtained, however, if the following three assumptions were valid:

- (a) the illumination of the sample 18 would need to be point-like, rather than illumination over a small area;
- 5 (b) all scattering would have to be from the focal plane of the lens 16, and not from adjacent planes above or below the focal point; and
- 10 (c) the Raman scattering would need to be caused by the interaction of photons with phonons having a very precisely defined frequency value, so that each Raman band is sharp and has a very narrow width (i.e. a precisely defined wave number).

In real life, of course, these assumptions cannot be completely satisfied. The result of non-satisfaction of assumptions (a) and (b) will be a blurring of the image, as indicated by the larger circles 62 in Fig 6, within the lines 46. The effect of not having a precisely defined phonon frequency (assumption (c)) is to broaden each of the 20 Raman bands, giving the lines 60A shown in Fig 7 in place of the spots 60 shown in Fig 6. Correspondingly, the blurring is now as shown by the ellipses 62A, instead of the circles 62. The purpose of confocal techniques such as in the preferred embodiments of the present invention is to 25 reduce the blurring effect particularly where assumption (b) is not satisfied.

The image processing algorithms which may be performed by software in the computer 25 have the effect of reducing or 30 removing the blurring, to recover the spots 60 from the circles 62, or to recover the lines 60A from the ellipses 62A. In either case, the first step of the algorithm is to read all the data of the image from the CCD into the memory of the computer 25 (or into a suitable storage medium such 35 as a hard disk). The data is stored within the computer in an array, having one storage location corresponding to each pixel of the CCD.

The next step of the algorithm is to scan the stored data in a direction corresponding to the direction X shown in Figs 6 and 7. This may be performed along a row of the stored array of data corresponding to one row of pixels

5 within the lines 44. From this scan, the algorithm determines the point of maximum illumination in the middle of each circle 62. In a simple case, in which the circles 62 are assumed to be truly circular, and no information is required about the width of each individual Raman band, the

10 algorithm can now output the position of each point of maximum illumination, in terms of the wave number of the corresponding Raman band. In this simple case, the algorithm can then (for each of the circles 62) determine the sum (or the average) of the values of the illumination

15 which have just been scanned within that circle 62. This value is also output, to give an intensity value associated with each Raman band.

A more complicated algorithm may scan all the pixels

20 between the lines 46 (i.e. a two-dimensional scan instead of the previous one-dimensional scan). For each of the circles 62, this algorithm then determines the centroid, and outputs the position of that centroid in the X direction, in terms of the wave number of the corresponding

25 Raman band. Again, the intensity of this Raman band may be determined by summing or averaging the values just scanned within the circle 62 concerned.

However, neither of the above two algorithms give

30 information about the width of the Raman band, as indicated by the lines 60A in Fig 7. Neither do they give information about the shape of the Raman band (i.e. the intensity distribution within the line 60A). More sophisticated image processing techniques may be utilised

35 if such information is required. For this, the software may perform an algorithm as follows. This algorithm is based upon the assumption that the ellipse 62A may be considered as a number of imaginary, overlapping circles

62B, each imaginary circle being centred upon a different pixel within the line 60A, and each imaginary circle corresponding to the blurring (produced in the same way as in a circle 62 in Fig 6).

5

This algorithm proceeds as follows. Firstly, the data for an ellipse 62A is scanned as previously, to determine the centroid or point of maximum illumination of the ellipse. Next, the data for a column of pixels which includes this 10 point is scanned in the Y direction, to determine the intensity distribution at various different radii from this centre point. As an approximation, it may be assumed that this intensity distribution corresponds to that of the imaginary circle which is centred on the pixel at the 15 centroid of the ellipse, and that this imaginary circle has the same distribution in the X direction. However, the distribution as measured in the X direction will not correspond, since this measured distribution will also include contributions from all the other imaginary circles.

20

The next step of the algorithm, therefore, is to repeat this scan in the Y direction, for each of the other imaginary circles. That is, a Y distribution is determined corresponding to each pixel along the line 60A. To obtain 25 a true intensity value for a given pixel in the line 60A, the algorithm next subtracts from the measured intensity value of that given pixel the contributions from all the other imaginary circles. For each of the imaginary circles, the value to be subtracted is the intensity value 30 for the appropriate radius within that circle, determined from the Y distribution scan corresponding to that circle. The appropriate radius to use corresponds to the distance between the pixel under consideration and the centre of the circle concerned. Such a subtraction takes place for each 35 of the imaginary circles. The whole process is repeated for every pixel along the line 60A.

The final step of this algorithm is to output the resulting intensity value for each pixel within the line 60A, along with the corresponding wave number (position in the X direction).

5

It is of course possible to devise even more sophisticated image processing algorithms if desired. For instance, algorithms may be devised to process blurring which is more complex than indicated by the circles 62 or ellipses 62A.

10 Examples include cases where the illuminated area 19 of the sample 18 has a non-uniform surface roughness, or has a faceted surface (e.g. diamond film).

15 The methods described above may be used in an analogous fashion for other spectroscopic techniques than Raman spectroscopy, e.g. fluorescence spectroscopy and infra-red spectroscopy.

**CLAIMS**

1. A spectroscopy method comprising:
  - illuminating a sample, to obtain therefrom a spectrum
  - 5 of scattered light;
  - analysing said spectrum;
  - passing at least one component of the analysed spectrum to a photodetector, light scattered from a given plane in the sample being focused on the photodetector while light
  - 10 scattered from other planes in the sample is not in focus on the photodetector; and
  - detecting light which is in focus on the photodetector, thereby reducing the effect of light scattered from said other planes in the sample.
- 15
2. A method according to claim 1, wherein the photodetector comprises an array of pixels, and the light which is in focus is detected by selectively binning together the data from some of the pixels.
- 20
3. A method according to claim 1 or claim 2, wherein said step of detecting light which is in focus on the photodetector provides confocal action in one dimension.
- 25
4. A method according to claim 3, wherein confocal action in a second dimension is provided by passing the light through a spatial filter.
5. A method according to any one of the preceding claims,
- 30
- wherein the photodetector comprises a two-dimensional array of pixels, and the light which is in focus is detected by processing data representing an image received by said array.
- 35
6. A method according to any one of the preceding claims, wherein said spectrum is a spectrum of Raman scattered light.

7. Spectroscopy apparatus comprising:  
means for illuminating a sample, to obtain therefrom a spectrum of scattered light:  
means for analysing said spectrum;  
5 a photodetector;  
means for passing at least one component of the analysed spectrum to the photodetector, light scattered from a given plane in the sample being focused on the photodetector while light scattered from other planes in 10 the sample is not in focus on the photodetector; and means for detecting light which is in focus on the photodetector, thereby reducing the effect of light scattered from said other planes in the sample.
- 15 8. Apparatus according to claim 7, wherein the photodetector comprises an array of pixels.
9. Apparatus according to claim 8, including means for selectively binning together the data from some of the 20 pixels.
10. Apparatus according to claim 8 or claim 9, wherein the photodetector comprises a two-dimensional array of pixels, and including computing means for receiving data from the 25 array, representing an image received by the array, and for processing said image data to detect the light which is in focus.
11. Apparatus according to any one of claims 7 to 10, 30 wherein said means for detecting light which is in focus on the photodetector provides confocal action in one dimension.
12. Apparatus according to claim 11, wherein a spatial 35 filter is provided, through which the light is passed, the spatial filter providing confocal action in a second dimension.

13. Apparatus according to any one of claims 7 to 12, wherein said spectrum is a spectrum of Raman scattered light.

Fig. 4.

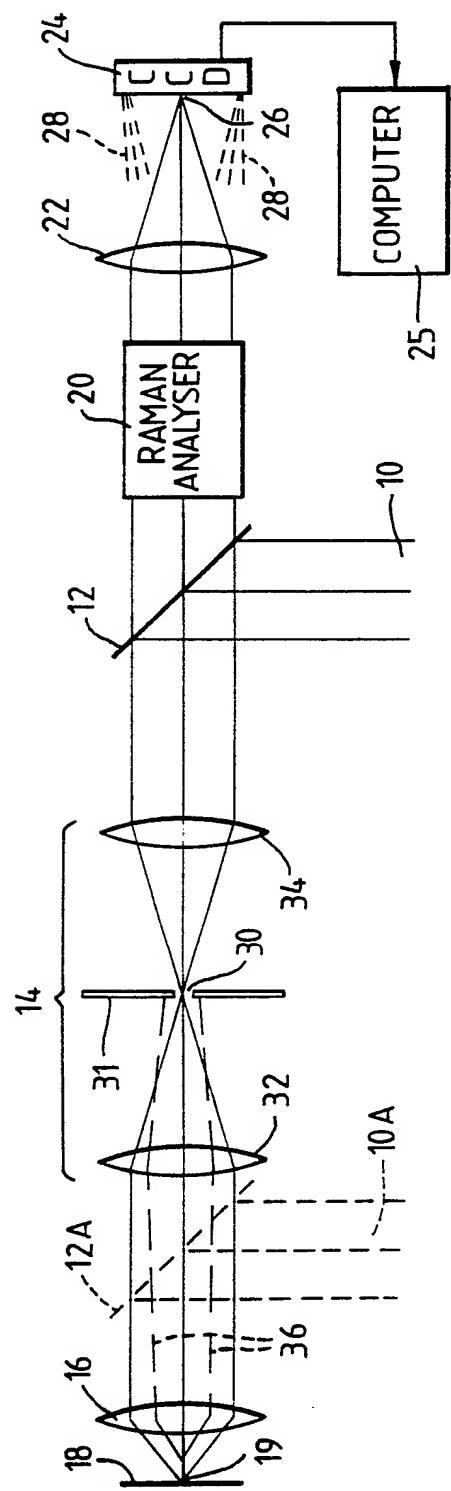
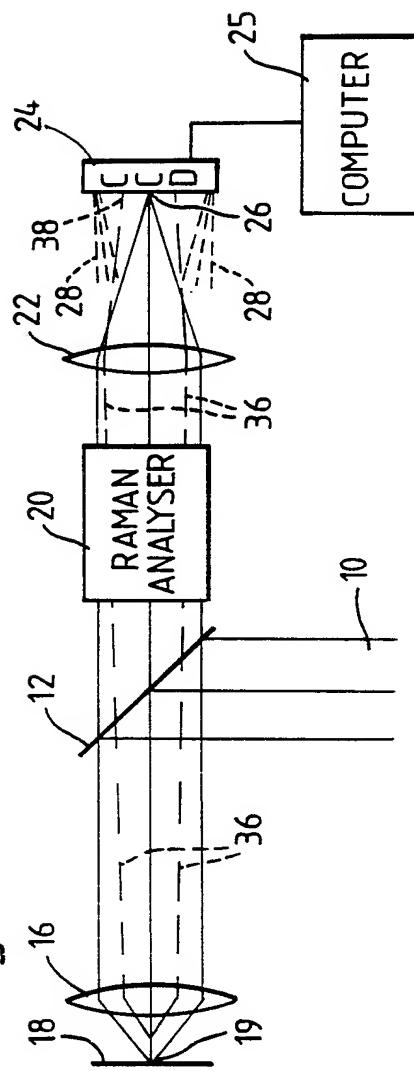


Fig. 1.



SUBSTITUTE SHEET

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Fig. 2.

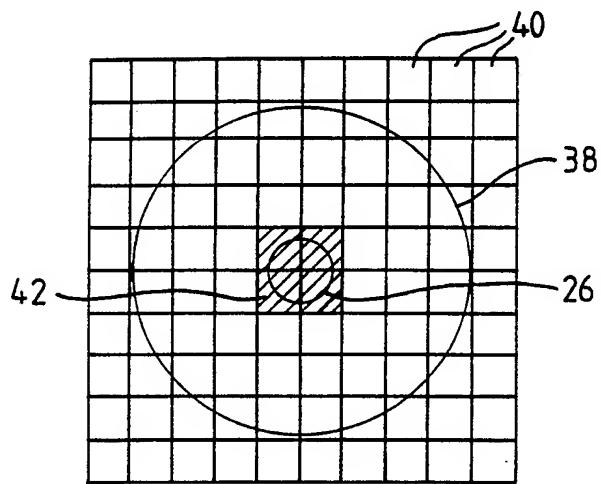


Fig. 3.

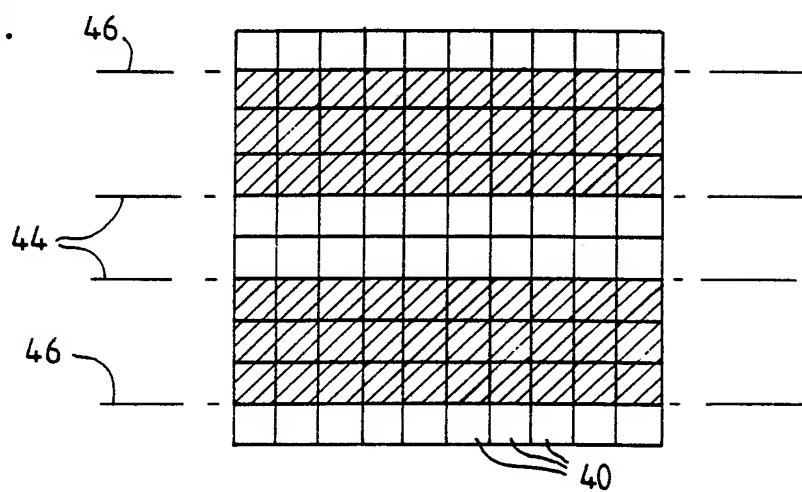
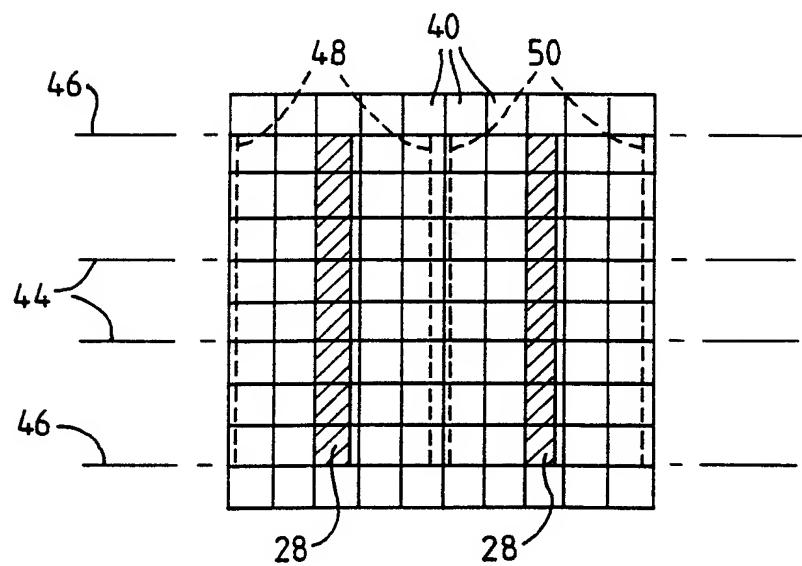


Fig. 5.



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Fig. 6.

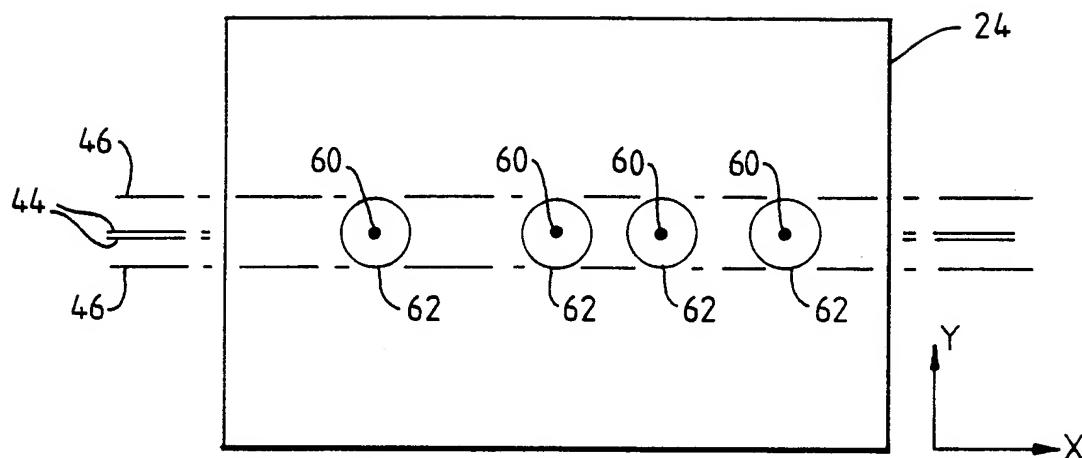
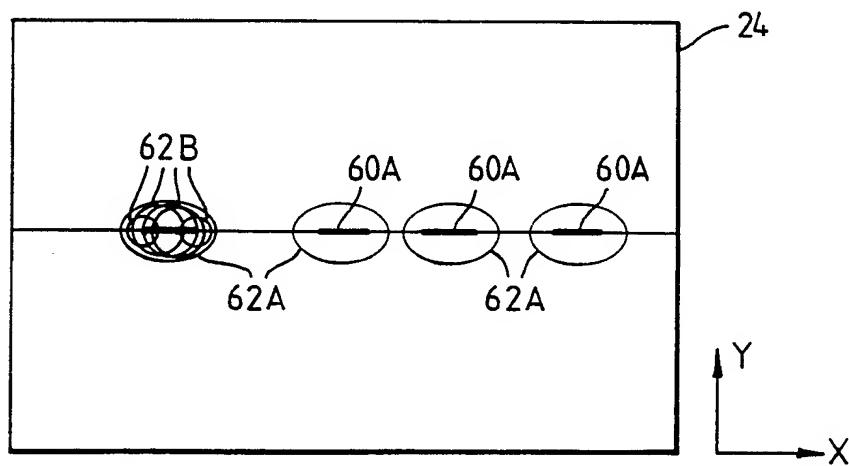


Fig. 7.



## INTERNATIONAL SEARCH REPORT

International Application No

PCT/GB 92/01026

I. CLASSIFICATION OF SUBJECT MATTER (if several classification symbols apply, indicate all)<sup>6</sup>

According to International Patent Classification (IPC) or to both National Classification and IPC

Int.C1. 5 G01J3/44

## II. FIELDS SEARCHED

Minimum Documentation Searched<sup>7</sup>

Classification System	Classification Symbols		
Int.C1. 5	G01J	;	G01N ; G02B

Documentation Searched other than Minimum Documentation  
to the Extent that such Documents are Included in the Fields Searched<sup>8</sup>III. DOCUMENTS CONSIDERED TO BE RELEVANT<sup>9</sup>

Category <sup>10</sup>	Citation of Document, <sup>11</sup> with indication, where appropriate, of the relevant passages <sup>12</sup>	Relevant to Claim No. <sup>13</sup>
X	NATURE vol. 347, 20 September 1990, pages 301 - 303; G.J.PUPPELS: 'studying single living cells and chromosomes by confocal raman microspectroscopy' see page 301 - page 303 ----	1,7
X	EP,A,0 380 904 (MICROSCAN IMAGING AND INSTRUMENTATION INC.) 8 August 1990 see claim 9 ----	1,5
X	WO,A,8 807 179 (THE SECRETARY OF STATE FOR DEFENCE) 22 September 1988 see claims 1-6 ----	7

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- <sup>&</sup> document member of the same patent family

## IV. CERTIFICATION

Date of the Actual Completion of the International Search

09 SEPTEMBER 1992

Date of Mailing of this International Search Report

18.09.92

International Searching Authority

EUROPEAN PATENT OFFICE

Signature of Authorized Officer

VAN DEN BULCKE E.J.

## III. DOCUMENTS CONSIDERED TO BE RELEVANT (CONTINUED FROM THE SECOND SHEET)

Category	Citation of Document, with indication, where appropriate, of the relevant passages	Relevant to Claim No.
A	<p>APPLIED OPTICS. vol. 29, no. 33, 20 November 1990, NEW YORK US pages 4969 - 4980; D.KIRK VEIRS ET AL.: 'mapping materials properties with raman spectroscopic utilizing a 2-d detector'</p> <p>----</p>	

ANNEX TO THE INTERNATIONAL SEARCH REPORT  
ON INTERNATIONAL PATENT APPLICATION NO. GB 9201026  
SA 60146

This annex lists the patent family members relating to the patent documents cited in the above-mentioned international search report.  
The members are as contained in the European Patent Office EDP file on  
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Patent document cited in search report	Publication date	Patent family member(s)		Publication date
EP-A-0380904	08-08-90	US-A-	4845552	04-07-89
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WO-A-8807179	22-09-88	AU-A-	1297588	10-10-88
		DE-A-	3871783	09-07-92
		EP-A, B	0343187	29-11-89
		GB-A-	2230601	24-10-90
		JP-T-	2502482	09-08-90
		US-A-	4975237	04-12-90
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